

## DB800ZL 8-OUTPUT PCIe GEN 3 BUFFER/ZERO DELAY BUFFER

### Features

- Eight 0.7 V low-power, push-pull, HCSL-compatible PCIe Gen 3 outputs
- Individual OE HW pins for each output clock
- 100 MHz /133 MHz PLL operation, supports PCIe and QPI
- SMBus address is 0xD8
- PLL or bypass mode
- Spread spectrum tolerable
- 1.05 to 3.3 V power supply voltage
- Low phase jitter (Intel QPI, PCIe Gen 1/2/3/4 common clock compliant)
- Gen 3 SRNS Compliant
- Industrial Temperature: -40 to 85 °C
- 48-pin QFN
- For higher output devices or variations of this device, contact Skyworks Solutions



### Applications

- Server
- Storage
- Datacenter
- Enterprise Switches and Routers

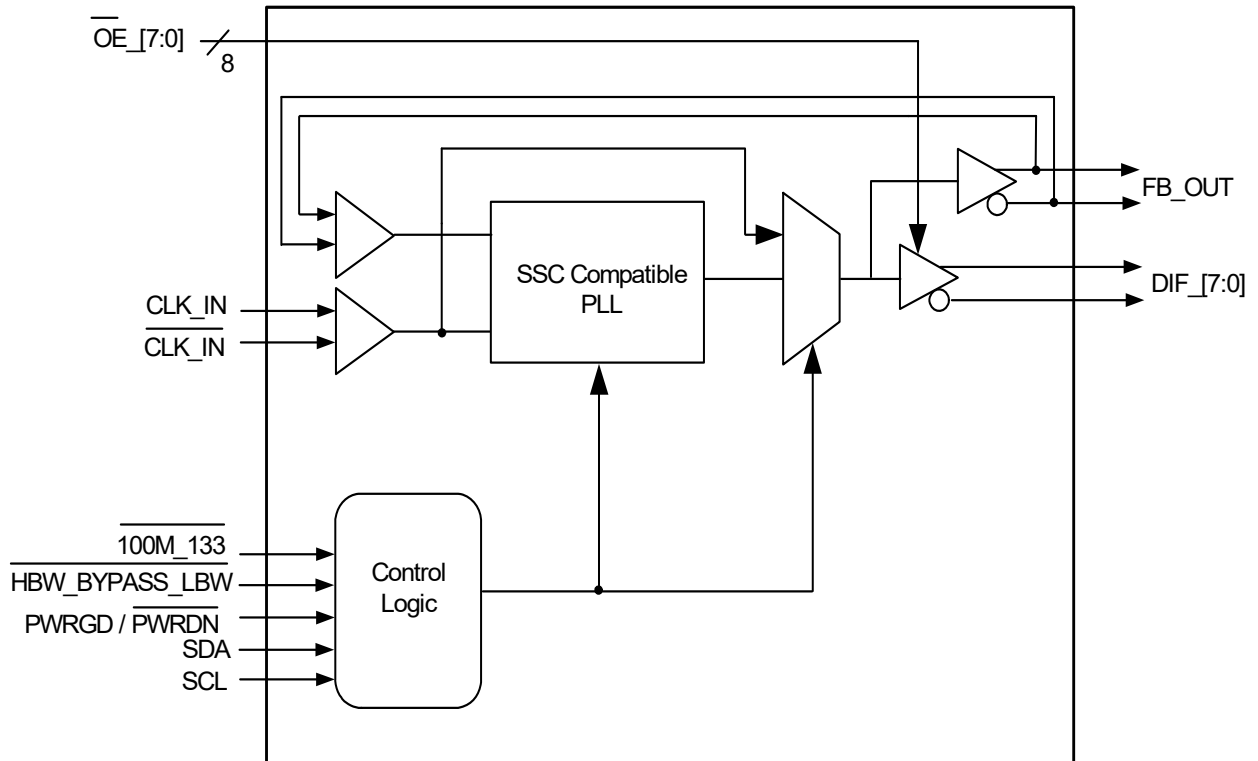
Patents pending

### Description

The Si53108 is a low-power, 8-output, differential clock buffer that meets all of the performance requirements of the Intel DB800ZL specification. The device is optimized for distributing reference clocks for Intel® Quick-Path Interconnect (Intel QPI), PCIe Gen 1/Gen 2/Gen 3/Gen 4, SAS, SATA, and Intel Scalable Memory Interconnect (Intel SMI) applications. The VCO of the device is optimized to support 100 MHz and 133 MHz operation. Each differential output has a dedicated hardware output enable pin for maximum flexibility and power savings. Measuring PCIe clock jitter is quick and easy with the Skyworks Solutions PCIe Clock Jitter Tool. Download it for free at <https://www.skyworksinc.com/en/application-pages/pci-express-learning-center>.

# Si53108

## Functional Block Diagram



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## 1. Electrical Specifications

**Table 1. Absolute Maximum Ratings**

| Parameter                               | Symbol             | Min  | Max | Unit |
|---|--------------------|------|-----|------|
| 3.3 V Core Supply Voltage <sup>1</sup>  | $V_{DD}/V_{DD\_A}$ | —    | 4.6 | V    |
| 3.3 V I/O Supply Voltage <sup>1</sup>   | $V_{DD\_IO}$       | —    | 4.6 | V    |
| 3.3 V Input High Voltage <sup>1,2</sup> | $V_{IH}$           | —    | 4.6 | V    |
| 3.3 V Input Low Voltage <sup>1</sup>    | $V_{IL}$           | -0.5 | —   | V    |
| Storage Temperature <sup>1</sup>        | $t_s$              | -65  | 150 | °C   |
| Input ESD protection <sup>3</sup>       | ESD                | 2000 | —   | V    |

**Notes:**

1. Consult manufacturer regarding extended operation in excess of normal DC operating parameters.
2. Maximum  $V_{IH}$  is not to exceed maximum  $V_{DD}$ .
3. Human body model.

**Table 2. DC Operating Characteristics**

$V_{DD\_A} = 3.3\text{ V} \pm 5\%$ ,  $V_{DD} = 3.3\text{ V} \pm 5\%$

| Parameter                              | Symbol             | Test Condition          | Min     | Max     | Unit          |
|--|--------------------|-------------------------|---------|---------|---------------|
| 3.3 V Core Supply Voltage              | $V_{DD}/V_{DD\_A}$ | 3.3 V $\pm 5\%$         | 3.135   | 3.465   | V             |
| 3.3 V Input High Voltage               | $V_{IH}$           | VDD                     | 2.0     | VDD+0.3 | V             |
| 3.3 V Input Low Voltage                | $V_{IL}$           |                         | VSS-0.3 | 0.8     | V             |
| Input Leakage Current <sup>1</sup>     | $I_{IL}$           | $0 < V_{IN} < V_{DD}$   | -5      | +5      | $\mu\text{A}$ |
| 3.3 V Input High Voltage <sup>2</sup>  | $V_{IH\_FS}$       | VDD                     | 0.7     | VDD+0.3 | V             |
| 3.3 V Input Low Voltage <sup>2</sup>   | $V_{IL\_FS}$       |                         | VSS-0.3 | 0.35    | V             |
| 3.3 V Input Low Voltage                | $V_{IL\_Tri}$      |                         | 0       | 0.8     | V             |
| 3.3 V Input Med Voltage                | $V_{IM\_Tri}$      |                         | 1.2     | 1.8     | V             |
| 3.3 V Input High Voltage               | $V_{IH\_Tri}$      |                         | 2.2     | VDD     | V             |
| 3.3 V Output High Voltage <sup>3</sup> | $V_{OH}$           | $I_{OH} = -1\text{ mA}$ | 2.4     | —       | V             |
| 3.3 V Output Low Voltage <sup>3</sup>  | $V_{OL}$           | $I_{OL} = 1\text{ mA}$  | —       | 0.4     | V             |
| Input Capacitance <sup>4</sup>         | $C_{IN}$           |                         | 2.5     | 4.5     | pF            |
| DIFF_IN Capacitance                    | $C_{DIF\_IN}$      |                         | 1.5     | 2.7     | pF            |
| Output pin Capacitance                 | $C_{OUT}$          |                         |         | 6       | pF            |
| Output Capacitance <sup>4</sup>        | $C_{OUT}$          |                         | 2.5     | 4.5     | pF            |
| Pin Inductance                         | $L_{PIN}$          |                         | —       | 7       | nH            |
| Ambient Temperature                    | $T_A$              | No Airflow              | -40     | 85      | °C            |

**Notes:**

1. Input Leakage Current does not include inputs with pull-up or pull-down resistors. Inputs with resistors should state current requirements.
2. Internal voltage reference is to be used to guarantee  $V_{IH\_FS}$  and  $V_{IL\_FS}$  thresholds levels over full operating range.
3. Signal edge is required to be monotonic when transitioning through this region.
4. Ccomp capacitance based on pad metallization and silicon device capacitance. Not including pin capacitance.

**Table 3. Clock Input Parameters** $T_A = -40$  to  $85$  °C; supply voltage  $V_{DD} = 3.3$  V  $\pm 5\%$ 

| Parameter                          | Symbol         | Test Condition                                  | Min            | Typ    | Max  | Unit    |
|------------------------------------|----------------|---|----------------|--------|------|---------|
| Input Frequency                    | $F_{IN}$       | Bypass Mode                                     | 33             | —      | 150  | MHz     |
|                                    |                | PLL Mode, 100 MHz                               | 90             | 100    | 110  | MHz     |
|                                    |                | PLL Mode, 133.33 MHz                            | 120            | 133.33 | 147  | MHz     |
| Input High Voltage- CLK_IN         | $V_{IHDIF}$    | Differential inputs<br>single-ended measurement | 600            | 800    | 1150 | mV      |
| Input Low Voltage- CLK_IN          | $V_{ILDIF}$    | Differential inputs<br>single-ended measurement | $V_{SS} - 300$ | 0      | 300  | mV      |
| Input Common Mode Voltage - CLK_IN | $V_{COM}$      | Common Mode Voltage Input                       | 300            | —      | 1000 | mV      |
| Input Amplitude- CLK_IN            | $V_{Swing}$    | Peak to Peak                                    | 300            | —      | 1450 |         |
| Input Slew Rate- CLK_IN            | $IDD_{VDDAPD}$ | Measured differentially                         | 0.4            | —      | 8    | V/ns    |
| Input Leakage Current              | $I_{IN}$       | $V_{IN} = V_{DD}$ , $V_{IN} = GND$              | -5             | —      | 5    | $\mu A$ |
| Input Duty Cycle                   | $d_{tin}$      | Measured from differential waveform             | 45             | —      | 55   | %       |
| Input Jitter, Cycle-Cycle          | $J_{DIFIN}$    | Differential measurement                        | 0              | —      | 125  | ps      |
| Input SS Modulation Frequency      | $f_{MODIN}$    | Triangle Wave Modulation                        | 30             | —      | 33   | kHz     |

**Table 4. Current Consumption** $T_A = -40$  to  $85$  °C; supply voltage  $V_{DD} = 3.3$  V  $\pm 5\%$ 

| Parameter          | Symbol         | Test Condition                 | Min | Typ | Max | Unit |
|--------------------|----------------|--------------------------------|-----|-----|-----|------|
| Operating Current  | $IDD_{VDD}$    | 133 MHz, VDD Rail              | —   | 79  | 90  | mA   |
|                    | $IDD_{VDDA}$   | 133 MHz, VDDA + VDDR, PLL Mode | —   | 14  | 20  | mA   |
| Power Down Current | $IDD_{VDDPD}$  | Power Down, VDD Rail           | —   | 1   | 1.5 | mA   |
|                    | $IDD_{VDDAPD}$ | Power Down, VDDA Rail          | —   | 4   | 8   | mA   |

**Table 5. Output Relational Timing Parameters**

$T_A = -40$  to  $85$  °C; supply voltage  $V_{DD} = 3.3$  V  $\pm 5\%$

| Parameter        | Test Condition  | Min  | TYP | Max | Unit | Notes   |
|------------------|---|------|-----|-----|------|---------|
| CLK_IN, DIF[x:0] | Input-to-Output Delay in PLL Mode<br>Nominal Value  | -100 | 20  | 100 | ps   | 1,2,4,5 |
| CLK_IN, DIF[x:0] | Input-to-Output Delay in Bypass Mode<br>Nominal Value   | 2.5  | 3.3 | 4.5 | ns   | 2,3,5   |
| CLK_IN, DIF[x:0] | Input-to-Output Delay Variation in PLL<br>mode (over voltage and temperature)<br>Nominal Value    | -100 | 39  | 100 | ps   | 2,3,5   |
| CLK_IN, DIF[x:0] | Input-to-Output Delay Variation in Bypass<br>Mode (over voltage and temperature)<br>Nominal Value | -250 |     | 250 | ps   | 2,3,5   |
| CLK_IN, DIF[7:0] | Output-to-Output Skew across all 12 out-<br>puts (Common to Bypass and PLL mode)                  | 0    | 25  | 50  | ps   | 1,2,3,5 |

**Notes:**

1. Measured into fixed 2 pF load cap. Input-to-output skew is measured at the first output edge following the corresponding input.
2. Measured from differential cross-point to differential cross-point.
3. All Bypass Mode Input-to-Output specs refer to the timing between an input edge and the specific output edge created by it.
4. This parameter is deterministic for a given device.
5. Measured with scope averaging on to find mean value

**Table 6. PLL Bandwidth and Peaking**

$T_A = -40$  to  $85$  °C; supply voltage  $V_{DD} = 3.3$  V  $\pm 5\%$

| Parameter          | Test Condition                    | Min | TYP | Max | Unit | Notes |
|--------------------|-----------------------------------|-----|-----|-----|------|-------|
| PLL Jitter Peaking | $\overline{HBW\_BYPASS\_LBW} = 0$ | —   | 0.4 | 2.0 | dB   | 2     |
| PLL Jitter Peaking | $\overline{HBW\_BYPASS\_LBW} = 1$ | —   | 0.1 | 2.0 | dB   | 2     |
| PLL Bandwidth      | $\overline{HBW\_BYPASS\_LBW} = 1$ | 2   | 3   | 4   | MHz  | 1     |
| PLL Bandwidth      | $\overline{HBW\_BYPASS\_LBW} = 0$ | 0.7 | 1   | 1.4 | MHz  | 1     |

**Notes:**

1. Measured at 3 db down or half power point.
2. Measured as maximum pass band gain. At frequencies with the loop BW, highest point of magnification is call PLL jitter peaking.

Table 7. Phase Jitter

| Parameter                | Test Condition   | Min | Typ  | Max  | Unit        |
|--------------------------|--|-----|------|------|-------------|
| Phase Jitter<br>PLL Mode | PCIe Gen 1, Common Clock <sup>1,2,7</sup>  | —   | 29   | 86   | ps          |
|                          | PCIe Gen 2 Low Band, Common Clock<br>F < 1.5 MHz <sup>1,2,3,4</sup>  | —   | 2.0  | 3.0  | ps<br>(RMS) |
|                          | PCIe Gen 2 High Band, Common Clock<br>1.5 MHz < F < Nyquist <sup>1,2,3,4</sup>                               | —   | 1.9  | 3.1  | ps<br>(RMS) |
|                          | PCIe Gen 3, Common Clock<br>(PLL BW 2–4 MHz, CDR = 10 MHz) <sup>1,2,3,4</sup>                                | —   | 0.45 | 1.0  | ps<br>(RMS) |
|                          | PCIe Gen 3 Separate Reference No Spread, SRNS<br>(PLL BW of 2–4 or 2–5 MHz, CDR = 10 MHz) <sup>1,3,4,5</sup> | —   | 0.32 | 0.71 | ps<br>(RMS) |
|                          | PCIe Gen 4, Common Clock<br>(PLL BW of 2–4 or 2–5 MHz, CDR = 10 MHz) <sup>1,4,5,8</sup>                      | —   | 0.45 | 1.0  | ps<br>(RMS) |
|                          | Intel® QPI & Intel SMI<br>(4.8 Gbps or 6.4 Gb/s, 100 or 133 MHz, 12 UI) <sup>1,5,6</sup>                     | —   | 0.21 | 0.5  | ps<br>(RMS) |
|                          | Intel QPI & Intel SMI<br>(8 Gb/s, 100 MHz, 12 UI) <sup>1,5</sup>   | —   | 0.13 | 0.3  | ps<br>(RMS) |
|                          | Intel QPI & Intel SMI<br>(9.6 Gb/s, 100 MHz, 12 UI) <sup>1,5</sup>   | —   | 0.11 | 0.2  | ps<br>(RMS) |

**Notes:**

1. Post processed evaluation through Intel supplied Matlab\* scripts. Defined for a BER of 1E-12. Measured values at a smaller sample size have to be extrapolated to this BER target.
2.  $\zeta = 0.54$  implies a jitter peaking of 3 dB.
3. PCIe\* Gen 3 filter characteristics are subject to final ratification by PCISIG. Check the PCI-SIG for the latest specification.
4. Measured on 100 MHz PCIe output using the template file in the Intel-supplied Clock Jitter Tool V1.6.3.
5. Measured on 100 MHz output using the template file in the Intel-supplied Clock Jitter Tool V1.6.3.
6. Measured on 100 MHz, 133 MHz output using the template file in the Intel-supplied Clock Jitter Tool V1.6.3.
7. These jitter numbers are defined for a BER of 1E-12. Measured numbers at a smaller sample size have to be extrapolated to this BER target.
8. Gen 4 specifications based on the PCI-Express Base Specification 4.0 rev. 0.5.
9. Download the Skyworks Solutions PCIe Clock Jitter Tool at <https://www.skyworksinc.com/en/application-pages/pci-express-learning-center>.

**Table 7. Phase Jitter (Continued)**

|                                      |  |   |      |   |             |
|--------------------------------------|--|---|------|---|-------------|
| Additive Phase Jitter<br>Bypass Mode | PCIe Gen 1 <sup>1,2,7</sup>  | — | 10   | — | ps          |
|                                      | PCIe Gen 2 Low Band<br>F < 1.5 MHz <sup>1,2,3,4</sup>                                    | — | 1.2  | — | ps<br>(RMS) |
|                                      | PCIe Gen 2 High Band<br>1.5 MHz < F < Nyquist <sup>1,2,3,4</sup>                         | — | 1.3  | — | ps<br>(RMS) |
|                                      | PCIe Gen 3<br>(PLL BW 2–4 MHz, CDR = 10 MHz) <sup>1,2,3,4</sup>                          | — | 0.25 | — | ps<br>(RMS) |
|                                      | PCIe Gen 4, Common Clock<br>(PLL BW of 2–4 or 2–5 MHz, CDR = 10 MHz) <sup>1,4,5,8</sup>  | — | 0.25 | — | ps<br>(RMS) |
|                                      | Intel QPI & Intel® SMI<br>(4.8 Gbps or 6.4 Gb/s, 100 or 133 MHz, 12 UI) <sup>1,5,6</sup> | — | 0.12 | — | ps<br>(RMS) |
|                                      | Intel QPI & Intel® SMI<br>(8 Gb/s, 100 MHz, 12 UI) <sup>1,5</sup>                        | — | 0.1  | — | ps<br>(RMS) |
|                                      | Intel QPI & Intel® SMI<br>(9.6 Gb/s, 100 MHz, 12 UI) <sup>1,5</sup>                      | — | 0.09 | — | ps<br>(RMS) |

**Notes:**

1. Post processed evaluation through Intel supplied Matlab\* scripts. Defined for a BER of 1E-12. Measured values at a smaller sample size have to be extrapolated to this BER target.
2.  $\zeta = 0.54$  implies a jitter peaking of 3 dB.
3. PCIe\* Gen 3 filter characteristics are subject to final ratification by PCISIG. Check the PCI-SIG for the latest specification.
4. Measured on 100 MHz PCIe output using the template file in the Intel-supplied Clock Jitter Tool V1.6.3.
5. Measured on 100 MHz output using the template file in the Intel-supplied Clock Jitter Tool V1.6.3.
6. Measured on 100 MHz, 133 MHz output using the template file in the Intel-supplied Clock Jitter Tool V1.6.3.
7. These jitter numbers are defined for a BER of 1E-12. Measured numbers at a smaller sample size have to be extrapolated to this BER target.
8. Gen 4 specifications based on the PCI-Express Base Specification 4.0 rev. 0.5.
9. Download the Skyworks Solutions PCIe Clock Jitter Tool at <https://www.skyworksinc.com/en/application-pages/pci-express-learning-center>.



Table 8. DIF 0.7 V AC Timing Characteristics (Non-Spread Spectrum Mode)

| Parameter                                     | Symbol                              | CLK 100 MHz, 133 MHz |     |                  | Unit | Notes      |
|---|-------------------------------------|----------------------|-----|------------------|------|------------|
|   |                                     | Min                  | Typ | Max              |      |            |
| Clock Stabilization Time                      | $T_{STAB}$                          | —                    | —   | 1.8              | ms   | 22         |
| Long Term Accuracy                            | $L_{ACC}$                           | —                    | —   | 100              | ppm  | 4,8,16     |
| Absolute Host CLK Period (100 MHz)            | $T_{ABS}$                           | 9.94900              | —   | 10.05100         | ns   | 4,5,8      |
| Absolute Host CLK Period (133 MHz)            | $T_{ABS}$                           | 7.44925              | —   | 7.55075          | ns   | 4,5,8      |
| Edge_rate                                     | Edge_rate                           | 1.0                  | —   | 4.0              | V/ns | 2,4,8      |
| Rise/Fall Matching                            | $T_{RISE\_MAT}/$<br>$T_{FALL\_MAT}$ | —                    | —   | 20               | %    | 4,7,19,21  |
| Voltage High (typ 0.7 V)                      | $V_{HIGH}$                          | 660                  | —   | 850              | mV   | 3,8, 12    |
| Voltage Low (typ 0.0 V)                       | $V_{LOW}$                           | -150                 | —   | 150              | mV   | 4,7,11     |
| Maximum Voltage                               | $V_{MAX}$                           | —                    | —   | 1150             | mV   | 7          |
| Absolute Crossing Point Voltages              | $V_{CROSS(a$<br>$bs)}$              | 300                  | —   | 550              | mV   | 1,3,4,7,14 |
| Total Variation of $V_{cross}$ Over All Edges | Total $\Delta$<br>$V_{CROSS}$       | —                    | —   | 140              | mV   | 4,7,15     |
| Cycle-to-Cycle Jitter                         | $T_{CCJITTER}$                      | —                    | —   | 50               | ps   | 4,8,20     |
| Duty Cycle                                    | Duty Cycle                          | 45                   | —   | 55               | %    | 4,8        |
| Maximum Voltage (Overshoot)                   | $V_{ovs}$                           | —                    | —   | $V_{High} + 0.3$ | V    | 4,7,12     |
| Maximum Voltage (Undershoot)                  | $V_{uds}$                           | —                    | —   | $V_{Low} - 0.3$  | V    | 4,7,13     |

**Table 8. DIF 0.7 V AC Timing Characteristics (Non-Spread Spectrum Mode) (Continued)**

| Parameter        | Symbol   | CLK 100 MHz, 133 MHz |     |     | Unit | Notes |
|------------------|----------|----------------------|-----|-----|------|-------|
|                  |          | Min                  | Typ | Max |      |       |
| Ringback Voltage | $V_{rb}$ | 0.2                  |     | N/A | V    | 4,7   |

**Notes:**

1. Measured at crossing point where the instantaneous voltage value of the rising edge of CLK equals the falling edge of CLK#
2. Measure taken from differential waveform on a component test board. The edge (slew) rate is measured from -150 mV to +150 mV on the differential waveform. Scope is set to average because the scope sample clock is making most of the dynamic wiggles along the clock edge Only valid for Rising clock and Falling Clock#. Signal must be monotonic through the  $V_{OL}$  to  $V_{OH}$  region for  $T_{RISE}$  and  $T_{FALL}$ .
3. This measurement refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing
4. Test configuration is  $R_S = 33.2 \Omega$ ,  $R_P = 49.9$ , 2 pF for 100  $\Omega$  transmission line;  $R_S = 27 \Omega$ ,  $R_P = 42.2$ , 2 pF for 85  $\Omega$  transmission line
5. The average period over any 1  $\mu$ s period of time must be greater than the minimum and less than the maximum specified period
6.  $V_{CROSS}(rel)$  Min and Max are derived using the following,  $V_{CROSS}(rel)$  Min =  $0.250 + 0.5 (V_{HAVG} - 0.700)$ ,  $V_{CROSS}(rel)$  Max =  $0.550 - 0.5 (0.700 - V_{HAVG})$  (see Figure 3-4 for further clarification)
7. Measurement taken from Single Ended waveform
8. Measurement taken from differential waveform
9. Unless otherwise noted, all specifications in this table apply to all processor frequencies
10.  $V_{HIGH}$  is defined as the statistical average High value as obtained by using the Oscilloscope  $V_{HIGH}$  Math function
11.  $V_{LOW}$  is defined as the statistical average Low value as obtained by using the Oscilloscope  $V_{LOW}$  Math function
12. Overshoot is defined as the absolute value of the maximum voltage
13. Undershoot is defined as the absolute value of the minimum voltage
14. The crossing point must meet the absolute and relative crossing point specifications simultaneously
15.  $\Delta V_{CROSS}$  is defined as the total variation of all crossing voltages of Rising CLOCK and Falling CLOCK#. This is the maximum allowed variance in  $V_{CROSS}$  for any particular system
16. Using frequency counter with the measurement interval equal or greater than 0.15 s, target frequencies are 100,000,000 Hz, 133,333,333 Hz
17. Using frequency counter with the measurement interval equal or greater than 0.15 s, target frequencies are 99,750,00 Hz, 133,000,000 Hz
18. Measured with oscilloscope, averaging off, using min max statistics. Variation is the delta between min and max.
19. Measured with oscilloscope, averaging on, The difference between the rising edge rate (average) of clock verses the falling edge rate (average) of clock#
20. Measured with device in PLL mode, in BYPASS mode jitter is additive (up to 25ps of cycle-to-cycle jitter may add to the input jitter)
21. Rise/Fall matching is derived using the following,  $2 * (T_{RISE} - T_{FALL}) / (T_{RISE} + T_{FALL})$
22. This is the time from the valid CLK\_IN input clocks and the assertion of the PWRGD signal level at 1.8 V – 2.0 V to the time that stable clocks are output from the buffer chip (PLL locked)

Table 9. DIF 0.7 V AC Timing Characteristics (–0.5% Spread Spectrum Mode)

| Parameter                                     | Symbol                              | CLK 100 MHz, 133 MHz |     |                  | Unit | Notes      |
|---|-------------------------------------|----------------------|-----|------------------|------|------------|
|   |                                     | Min                  | Typ | Max              |      |            |
| Clock Stabilization Time                      | $T_{STAB}$                          | —                    |     | 1.8              | ms   | 22         |
| Long Term Accuracy                            | $L_{ACC}$                           | —                    |     | 100              | ppm  | 4,8,16     |
| Absolute Host CLK Period (100 MHz)            | $T_{ABS}$                           | 9.94900              |     | 10.10126         | ns   | 4,5,8      |
| Absolute Host CLK Period (133 MHz)            | $T_{ABS}$                           | 7.44925              |     | 7.58845          | ns   | 4,5,8      |
| Edge_rate                                     | Edge_rate                           | 1.0                  |     | 4.0              | V/ns | 2,4,8      |
| Rise/Fall Matching                            | $T_{RISE\_MAT}/$<br>$T_{FALL\_MAT}$ | —                    |     | 20               | %    | 4,7,19,21  |
| Voltage High (typ 0.70 V)                     | $V_{HIGH}$                          | 660                  |     | 850              | mV   | 4,7,10     |
| Voltage Low (typ 0.0 V)                       | $V_{LOW}$                           | –150                 |     | 150              | mV   | 4,7,11     |
| Maximum Voltage                               | $V_{MAX}$                           | —                    |     | 1150             | mV   | 7          |
| Absolute Crossing Point Voltages              | $V_{CROSS(a$<br>$bs)}$              | 300                  |     | 550              | mV   | 1,3,4,7,14 |
| Relative Crossing Point Voltages              | $V_{CROSS(re$<br>$l)}$              | Calc                 |     | Calc             | mV   | 4,6,7,14   |
| Total Variation of $V_{cross}$ Over All Edges | Total $\Delta$<br>$V_{CROSS}$       | —                    |     | 140              | mV   | 4,7,15     |
| Cycle-to-Cycle Jitter                         | $T_{CCJITTER}$                      |                      |     | 50               | ps   | 4,8,20     |
| Duty Cycle                                    | Duty Cycle                          | 45                   |     | 55               | %    | 4,8        |
| Maximum Voltage (Overshoot)                   | $V_{ovs}$                           | —                    |     | $V_{High} + 0.3$ | V    | 4,7,12     |
| Maximum Voltage (Undershoot)                  | $V_{uds}$                           | —                    |     | $V_{Low} - 0.3$  | V    | 4,7,13     |

**Table 9. DIF 0.7 V AC Timing Characteristics (–0.5% Spread Spectrum Mode) (Continued)**

| Parameter  | Symbol   | CLK 100 MHz, 133 MHz |     |     | Unit | Notes |
|--|----------|----------------------|-----|-----|------|-------|
|  |          | Min                  | Typ | Max |      |       |
| Ringback Voltage   | $V_{rb}$ | 0.2                  |     | N/A | V    | 4,7   |
| <b>Notes:</b>  |          |                      |     |     |      |       |
| <ol style="list-style-type: none"> <li>1. Measured at crossing point where the instantaneous voltage value of the rising edge of CLK equals the falling edge of CLK#</li> <li>2. Measure taken from differential waveform on a component test board. The edge (slew) rate is measured from -150 mV to +150 mV on the differential waveform. Scope is set to average because the scope sample clock is making most of the dynamic wiggles along the clock edge Only valid for Rising clock and Falling Clock#. Signal must be monotonic through the <math>V_{OL}</math> to <math>V_{OH}</math> region for <math>T_{RISE}</math> and <math>T_{FALL}</math>.</li> <li>3. This measurement refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing</li> <li>4. Test configuration is <math>R_S = 33.2 \Omega</math>, <math>R_P = 49.9</math>, 2 pF for 100 <math>\Omega</math> transmission line; <math>R_S = 27 \Omega</math>, <math>R_P = 42.2</math>, 2 pF for 85 <math>\Omega</math> transmission line</li> <li>5. The average period over any 1 <math>\mu</math>s period of time must be greater than the minimum and less than the maximum specified period</li> <li>6. <math>V_{CROSS}(rel)</math> Min and Max are derived using the following, <math>V_{CROSS}(rel)</math> Min = <math>0.250 + 0.5 (V_{HAVG} - 0.700)</math>, <math>V_{CROSS}(rel)</math> Max = <math>0.550 - 0.5 (0.700 - V_{HAVG})</math> (see Figure 3-4 for further clarification)</li> <li>7. Measurement taken from Single Ended waveform</li> <li>8. Measurement taken from differential waveform</li> <li>9. Unless otherwise noted, all specifications in this table apply to all processor frequencies</li> <li>10. <math>V_{HIGH}</math> is defined as the statistical average High value as obtained by using the Oscilloscope <math>V_{HIGH}</math> Math function</li> <li>11. <math>V_{LOW}</math> is defined as the statistical average Low value as obtained by using the Oscilloscope <math>V_{LOW}</math> Math function</li> <li>12. Overshoot is defined as the absolute value of the maximum voltage</li> <li>13. Undershoot is defined as the absolute value of the minimum voltage</li> <li>14. The crossing point must meet the absolute and relative crossing point specifications simultaneously</li> <li>15. <math>\Delta V_{CROSS}</math> is defined as the total variation of all crossing voltages of Rising CLOCK and Falling CLOCK#. This is the maximum allowed variance in <math>V_{CROSS}</math> for any particular system</li> <li>16. Using frequency counter with the measurement interval equal or greater than 0.15 s, target frequencies are 100,000,000 Hz, 133,333,333 Hz</li> <li>17. Using frequency counter with the measurement interval equal or greater than 0.15 s, target frequencies are 99,750,00 Hz, 133,000,000 Hz</li> <li>18. Measured with oscilloscope, averaging off, using min max statistics. Variation is the delta between min and max.</li> <li>19. Measured with oscilloscope, averaging on, The difference between the rising edge rate (average) of clock verses the falling edge rate (average) of clock#</li> <li>20. Measured with device in PLL mode, in BYPASS mode jitter is additive (up to 25ps of cycle-to-cycle jitter may add to the input jitter)</li> <li>21. Rise/Fall matching is derived using the following, <math>2 * (T_{RISE} - T_{FALL}) / (T_{RISE} + T_{FALL})</math></li> <li>22. This is the time from the valid CLK_IN input clocks and the assertion of the PWRGD signal level at 1.8 V – 2.0 V to the time that stable clocks are output from the buffer chip (PLL locked)</li> </ol> |          |                      |     |     |      |       |

Table 10. Clock Periods Differential Clock Outputs with SSC Disabled

| SSC ON<br>Center<br>Freq, MHz | Measurement Window              |                                  |                                 |                            |                                 |                                  |                                 | Unit |
|-------------------------------|---------------------------------|----------------------------------|---------------------------------|----------------------------|---------------------------------|----------------------------------|---------------------------------|------|
|                               | 1 Clock                         | 1 $\mu$ s                        | 0.1 s                           | 0.1 s                      | 0.1 s                           | 1 $\mu$ s                        | 1 Clock                         |      |
|                               | -C-C<br>Jitter<br>AbsPer<br>Min | -SSC<br>Short<br>Term AVG<br>Min | -ppm<br>Long<br>Term AVG<br>Min | 0 ppm<br>Period<br>Nominal | +ppm<br>Long<br>Term AVG<br>Max | +SSC<br>Short<br>Term AVG<br>Max | +C-C<br>Jitter<br>AbsPer<br>Max |      |
| 100.00                        | 9.94900                         |                                  | 9.99900                         | 10.00000                   | 10.00100                        |                                  | 10.05100                        | ns   |
| 133.33                        | 7.44925                         |                                  | 7.49925                         | 7.50000                    | 7.50075                         |                                  | 7.55075                         | ns   |

Table 11. Clock Periods Differential Clock Outputs with SSC Enabled

| SSC ON<br>Center<br>Freq, MHz | Measurement Window              |                                  |                                 |                            |                                 |                                  |                                 | Unit |
|-------------------------------|---------------------------------|----------------------------------|---------------------------------|----------------------------|---------------------------------|----------------------------------|---------------------------------|------|
|                               | 1 Clock                         | 1 $\mu$ s                        | 0.1 s                           | 0.1 s                      | 0.1 s                           | 1 $\mu$ s                        | 1 Clock                         |      |
|                               | -C-C<br>Jitter<br>AbsPer<br>Min | -SSC<br>Short<br>Term AVG<br>Min | -ppm<br>Long<br>Term AVG<br>Min | 0 ppm<br>Period<br>Nominal | +ppm<br>Long<br>Term AVG<br>Max | +SSC<br>Short<br>Term AVG<br>Max | +C-C<br>Jitter<br>AbsPer<br>Max |      |
| 99.75                         | 9.94900                         | 9.99900                          | 10.02406                        | 10.02506                   | 10.02607                        | 10.05126                         | 10.10126                        | ns   |
| 133.33                        | 7.44925                         | 7.49925                          | 7.51805                         | 7.51880                    | 7.51955                         | 7.53845                          | 7.58845                         | ns   |

## 2. Functional Description

### 2.1. CLK\_IN, $\overline{\text{CLK\_IN}}$

The differential input clock can be sourced from a clock synthesizer, e.g. CK420BQ, CK509B, or CK410B+.

### 2.2. $\overline{\text{OE}}$ and Output Enables (Control Registers)

Each output can be individually enabled or disabled by SMBus control register bits. Additionally, each output of the DIF[7:0] has a dedicated  $\overline{\text{OE}}$  pin. The  $\overline{\text{OE}}$  pins are asynchronous, asserted-low signals. The Output Enable bits in the SMBus registers are active high and are set to enable by default. The disabled state for the Si53108 NMOS push-pull output is Low/Low. Please note that the logic level for assertion or deassertion is different in software than it is on hardware. This follows hardware default nomenclature for communication channels (e.g., output is enabled if the OE# pin is pulled low) and still maintains software programming logic (e.g., output is enabled if OE register is true). Table 12 is a truth table depicting enabling and disabling of outputs via hardware and software. Note that, for the output to be active, the control register bit must be a 1 *and* the  $\overline{\text{OE}}$  pin must be a 0.

**Note:** The assertion and deassertion of this signal is absolutely asynchronous.

**Table 12. Si53108 Output Management**

| Inputs                             |                                     | $\overline{\text{OE}}$ Hardware Pins and Control Register Bits |                            |                                     | Outputs                             | PLL State |
|------------------------------------|-------------------------------------|--|----------------------------|-------------------------------------|-------------------------------------|-----------|
| PWRGD/ $\overline{\text{PWR\_DN}}$ | CLK_IN/ $\overline{\text{CLK\_IN}}$ | SMBUS Enable Bit   | $\overline{\text{OE}}$ Pin | DIF/ $\overline{\text{DIF}}$ [11:0] | FB_OUT/ $\overline{\text{FB\_OUT}}$ |           |
| 0                                  | x                                   | x  | x                          | Low/Low                             | Low/Low                             | OFF       |
| 1                                  | Running                             | 0  | x                          | Low/Low                             | Running                             | ON        |
|                                    |                                     | 1  | 0                          | Running                             | Running                             | ON        |
|                                    |                                     | 1  | 1                          | Low/Low                             | Running                             | ON        |

#### 2.2.1. $\overline{\text{OE}}$ Assertion (Transition from 1 to 0)

All differential outputs that were disabled are to resume normal operation in a glitch-free manner. The latency from the assertion to active outputs is 4 to 12 DIF clock periods.

#### 2.2.2. $\overline{\text{OE}}$ De-Assertion (Transition from 0 to 1)

The impact of deasserting  $\overline{\text{OE}}$  is that each corresponding output will transition from normal operation to disabled in a glitch-free manner. A minimum of four valid clocks will be provided after the deassertion of  $\overline{\text{OE}}$ . The maximum latency from the deassertion to disabled outputs is 12 DIF clock periods.

### 2.3. 100M\_133M—Frequency Selection

The Si53108 is optimized for lowest phase jitter performance at operating frequencies of 100 and 133 MHz. 100M\_133M is a hardware input pin, which programs the appropriate output frequency of the differential outputs. Note that the CLK\_IN frequency must be equal to the CLK\_OUT frequency; meaning Si53108 is operated in 1:1 mode only. Frequency selection can be enabled by the 100M\_133M hardware pin. An external pull-up or pull-down resistor is attached to this pin to select the input/output frequency. The functionality is summarized in Table 13.

**Table 13. Frequency Program Table**

| 100M_133M | Optimized Frequency (CLK_IN = CLK_OUT) |
|-----------|--|
| 0         | 133.33 MHz                             |
| 1         | 100.00 MHz                             |

**Note:** All differential outputs transition from 100 to 133 MHz or from 133 to 100 MHz in a glitch free manner.

## 2.4. PWRGD/PWRDN

PWRGD is asserted high and deasserted low. Deassertion of PWRGD (pulling the signal low) is equivalent to indicating a power-down condition. PWRGD (assertion) is used by the Si53108 to sample initial configurations, such as frequency select condition and SA selections. After PWRGD has been asserted high for the first time, the pin becomes a PWRDN (Power Down) pin that can be used to shut off all clocks cleanly and instruct the device to invoke power-saving mode. PWRDN is a completely asynchronous active low input. When entering power-saving mode, PWRDN should be asserted low prior to shutting off the input clock or power to ensure all clocks shut down in a glitch free manner. When PWRDN is asserted low, all clocks will be disabled prior to turning off the VCO. When PWRDN is deasserted high, all clocks will start and stop without any abnormal behavior and will meet all AC and DC parameters.

**Note:** The assertion and deassertion of  $\overline{\text{PWRDN}}$  is absolutely asynchronous.

**Warning:** Disabling of the CLK\_IN input clock prior to assertion of  $\overline{\text{PWRDN}}$  is an undefined mode and not recommended. Operation in this mode may result in glitches, excessive frequency shifting, etc.

**Table 14. PWRGD/PWRDN Functionality**

| $\overline{\text{PWRGD/PWRDN}}$ | DIF    | $\overline{\text{DIF}}$ |
|---------------------------------|--------|-------------------------|
| 0                               | Low    | Low                     |
| 1                               | Normal | Normal                  |

## 2.4.1. PWRDN Assertion

When  $\overline{\text{PWRDN}}$  is sampled low by two consecutive rising edges of  $\overline{\text{DIF}}$ , all differential outputs must be held LOW/LOW on the next  $\overline{\text{DIF}}$  high-to-low transition.

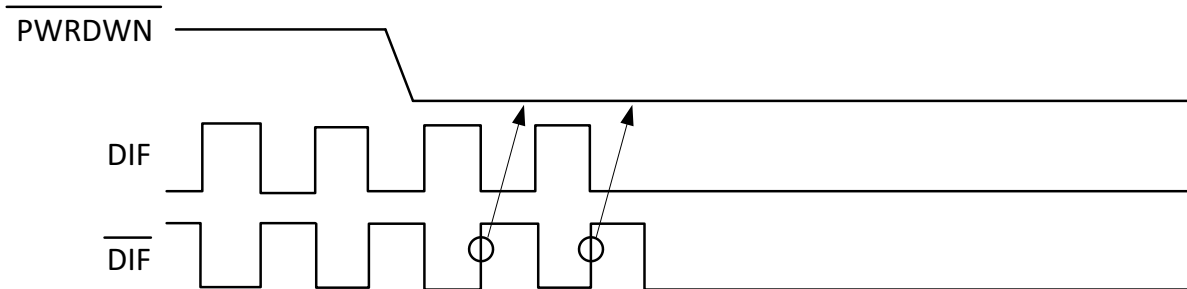


Figure 1.  $\overline{\text{PWRDN}}$  Assertion

## 2.4.2. PWRGD Assertion

The power-up latency is to be less than 1.8 ms. This is the time from a valid  $\text{CLK\_IN}$  input clock and the assertion of the  $\text{PWRGD}$  signal to the time that stable clocks are output from the device (PLL locked). All differential outputs stopped in a LOW/LOW condition resulting from power down must be driven high in less than 300  $\mu\text{s}$  of  $\overline{\text{PWRDN}}$  deassertion to a voltage greater than 200 mV.

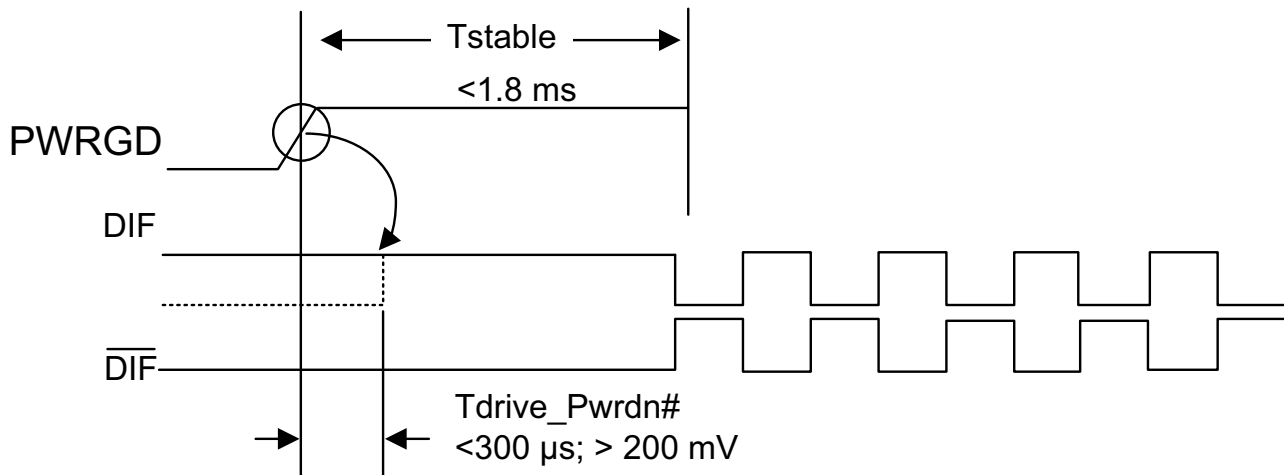


Figure 2. PWRGD Assertion (Pwrdn—Deassertion)



## 2.5. HBW\_BYPASS\_LBW

The HBW\_BYPASS\_LBW pin is a tri-level function input pin (refer to Table 15 for  $V_{IL\_Tri}$ ,  $V_{IM\_Tri}$ , and  $V_{IH\_Tri}$  signal levels). It is used to select between PLL high-bandwidth, PLL bypass mode, or PLL low-bandwidth mode. In PLL bypass mode, the input clock is passed directly to the output stage, which may result in up to 50 ps of additive cycle-to-cycle jitter (50 ps + input jitter) on the differential outputs. In the case of PLL mode, the input clock is passed through a PLL to reduce high-frequency jitter. The PLL HBW, BYPASS, and PLL LBW modes may be selected by asserting the HBW\_BYPASS\_LBW input pin to the appropriate level described in Table 15.

**Table 15. PLL Bandwidth and Readback Table**

| HBW_BYPASS_LBW Pin | Mode   | Byte 0, Bit 7 | Byte 0, Bit 6 |
|--------------------|--------|---------------|---------------|
| L                  | LBW    | 0             | 0             |
| M                  | BYPASS | 0             | 1             |
| H                  | HBW    | 1             | 1             |

The Si53108 has the ability to override the latch value of the PLL operating mode from hardware strap pin 5 via the use of Byte 0 and bits 2 and 1. Byte 0 bit 3 must be set to 1 to allow the user to change Bits 2 and 1, affecting the PLL. Bits 7 and 6 will always read back the original latched value. A warm reset of the system will have to be accomplished if the user changes these bits.

## 2.6. SMBUS Address

**Table 16. SMBUS Address**

| Address | LSB         |
|---------|-------------|
| 1101100 | +Read/Write |

## 2.7. Miscellaneous Requirements

**Data Transfer Rate:** 100 kbps (standard mode) is the base functionality required. Fast mode (400 kbps) functionality is optional.

**Logic Levels:** SMBus logic levels are based on a percentage of  $V_{DD}$  for the controller and other devices on the bus. Assume all devices are based on a 3.3 V supply.

**Clock Stretching:** The clock buffer must not hold/stretch the SCL or SDA lines low for more than 10 ms. Clock stretching is discouraged and should only be used as a last resort. Stretching the clock/data lines for longer than this time puts the device in an error/time-out mode and may not be supported in all platforms. It is assumed that all data transfers can be completed as specified without the use of clock/data stretching.

**General Call:** It is assumed that the clock buffer will not have to respond to the “general call.”

**Electrical Characteristics:** All electrical characteristics must meet the standard mode specifications found in Section 3 of the SMBus 2.0 specification.

**Pull-Up Resistors:** Any internal resistor pull-ups on the SDATA and SCLK inputs must be stated in the individual datasheet. The use of internal pull-ups on these pins of below 100 K is discouraged. Assume that the board designer will use a single external pull-up resistor for each line and that these values are in the 5–6 k $\Omega$  range. Assume one SMBus device per DIMM (serial presence detect), one SMBus controller, one clock buffer, one clock driver plus one/two more SMBus devices on the platform for capacitive loading purposes.

**Input Glitch Filters:** Only fast mode SMBus devices require input glitch filters to suppress bus noise. The clock buffer is specified as a standard mode device and is not required to support this feature. However, it is considered a good design practice to include the filters.

**PWRDN:** If a clock buffer is placed in PWRDN mode, the SDATA and SCLK inputs must be Tri-stated and the device must retain all programming information. IDD current due to the SMBus circuitry must be characterized and in the data sheet.

## 3. Test and Measurement Setup

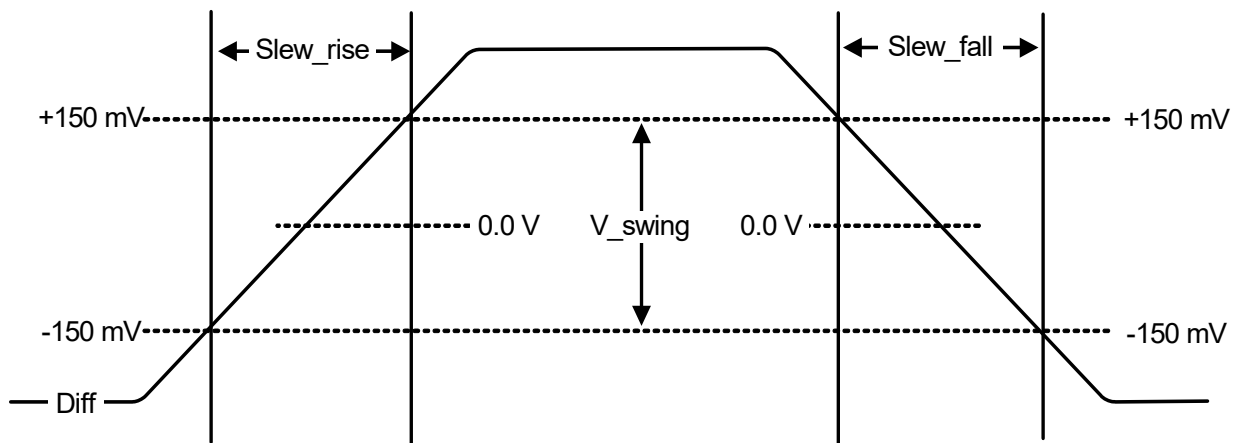
### 3.1. Input Edge

Input edge rate is based on single-ended measurement. This is the minimum input edge rate at which the Si53108 is guaranteed to meet all performance specifications.

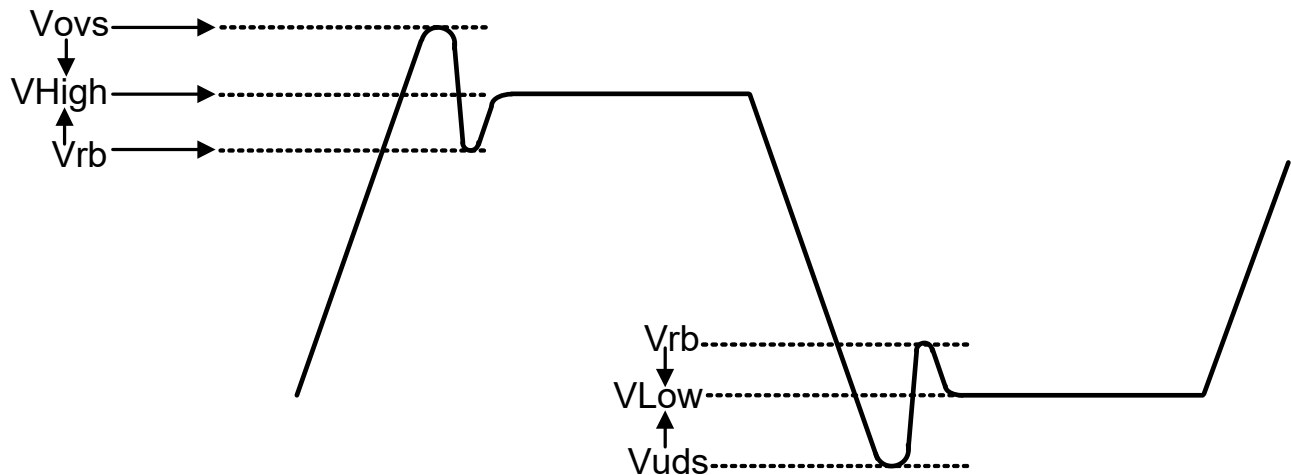
**Table 17. Input Edge Rate**

| Frequency | Min  | Max | Unit |
|-----------|------|-----|------|
| 100 MHz   | 0.35 | N/A | V/ns |
| 133 MHz   | 0.35 | N/A | V/ns |

#### 3.1.1. Measurement Points for Differential



**Figure 3. Measurement Points for Rise Time and Fall Time**



**Figure 4. Single-Ended Measurement Points for  $V_{OVS}$ ,  $V_{UDS}$ ,  $V_{Rb}$**

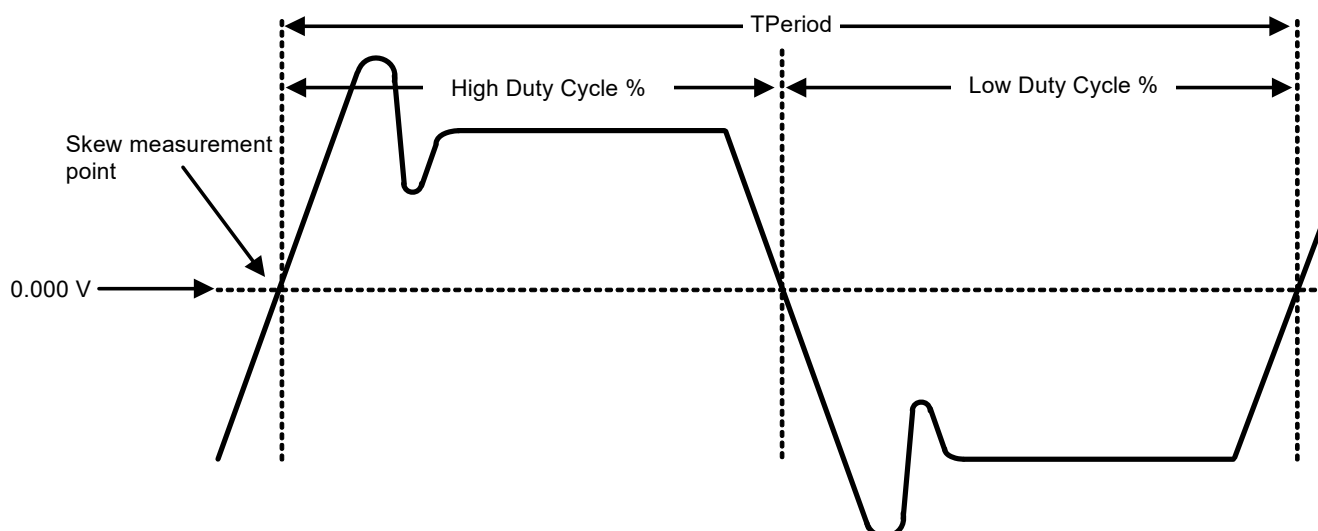


Figure 5. Differential (CLOCK-CLOCK) Measurement Points ( $T_{\text{period}}$ , Duty Cycle, Jitter)

### 3.2. Termination of Differential Outputs

All differential outputs are to be tested into a  $100\ \Omega$  or  $85\ \Omega$  differential impedance transmission line. Source terminated clocks have some inherent limitations as to the maximum trace length and frequencies that can be supported. For CPU outputs, a maximum trace length of 10" and a maximum of 200 MHz are assumed. For SRC clocks, a maximum trace length of 16" and maximum frequency of 100 MHz is assumed. For frequencies beyond 200 MHz, trace lengths must be restricted to avoid signal integrity problems.

Table 18. Differential Output Termination

| Clock                                   | Board Trace Impedance | $R_s$       | $R_p$ | Unit     |
|---|-----------------------|-------------|-------|----------|
| DIFF Clocks— $50\ \Omega$ configuration | 100                   | $33\pm 5\%$ | N/A   | $\Omega$ |
| DIFF Clocks— $43\ \Omega$ configuration | 85                    | $27\pm 5\%$ | N/A   | $\Omega$ |

#### 3.2.1. Termination of Differential NMOS Push-Pull Type Outputs

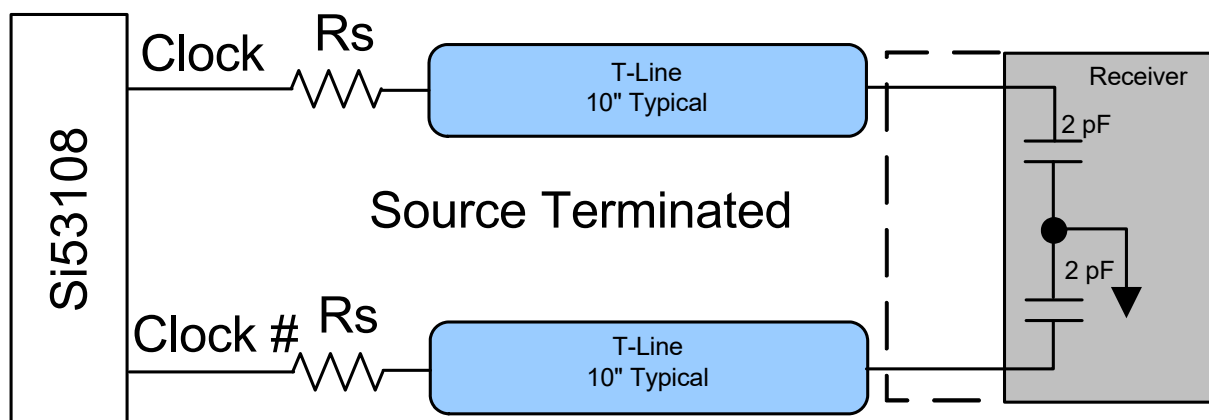


Figure 6. 0.7 V Configuration Test Load Board Termination for NMOS Push-Pull

## 4. Control Registers

### 4.1. Byte Read/Write

Reading or writing a register in an SMBus slave device in byte mode always involves specifying the register number.

#### 4.1.1. Byte Read

The standard byte read is as shown in Figure 7. It is an extension of the byte write. The write start condition is repeated; then, the slave device starts sending data, and the master acknowledges it until the last byte is sent. The master terminates the transfer with a NAK, then a stop condition. For byte operation, the 2 x 7th bit of the command byte must be set. For block operations, the 2 x 7th bit must be reset. If the bit is not set, the next byte must be the byte transfer count.

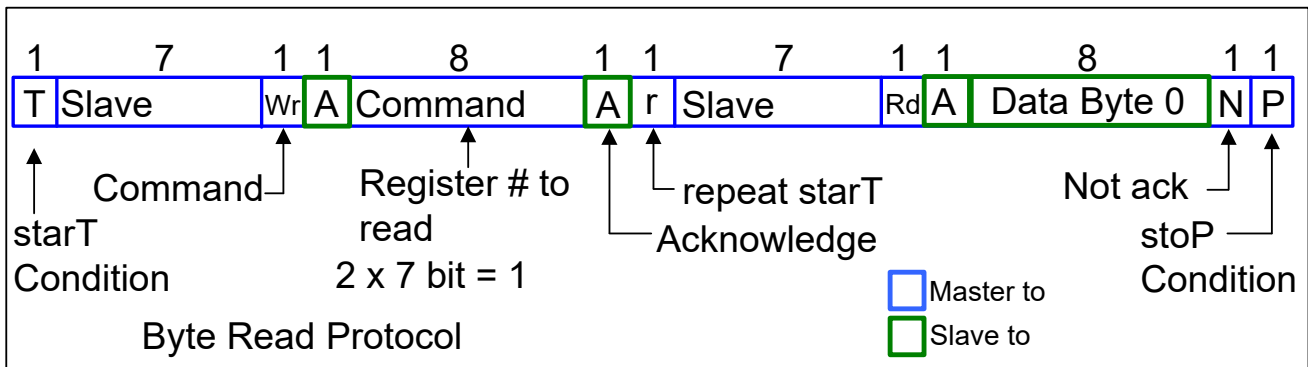


Figure 7. Byte Read Protocol

#### 4.1.2. Byte Write

Figure 8 illustrates a simple, typical byte write. For byte operation, the 2 x 7th bit of the command byte must be set. For block operations, the 2 x 7th bit must be reset. If the bit is not set, the next byte must be the byte transfer count. The count can be between 1 and 32. It is not allowed to be zero or to exceed 32.

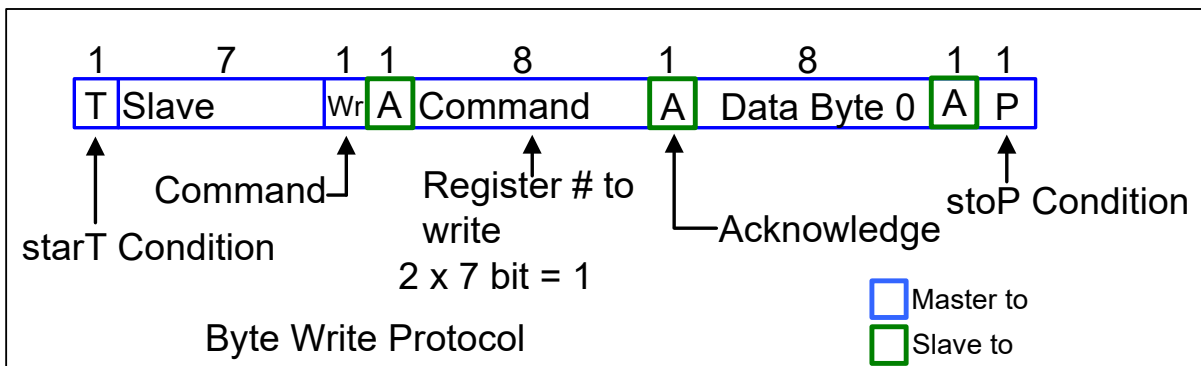


Figure 8. Byte Write Protocol

## 4.2. Block Read/Write

### 4.2.1. Block Read

After the slave address is sent with the R/W condition bit set, the command byte is sent with the MSB = 0. The slave acknowledges the register index in the command byte. The master sends a repeat start function. After the slave acknowledges this, the slave sends the number of bytes it wants to transfer (>0 and <33). The master acknowledges each byte except the last and sends a stop function.

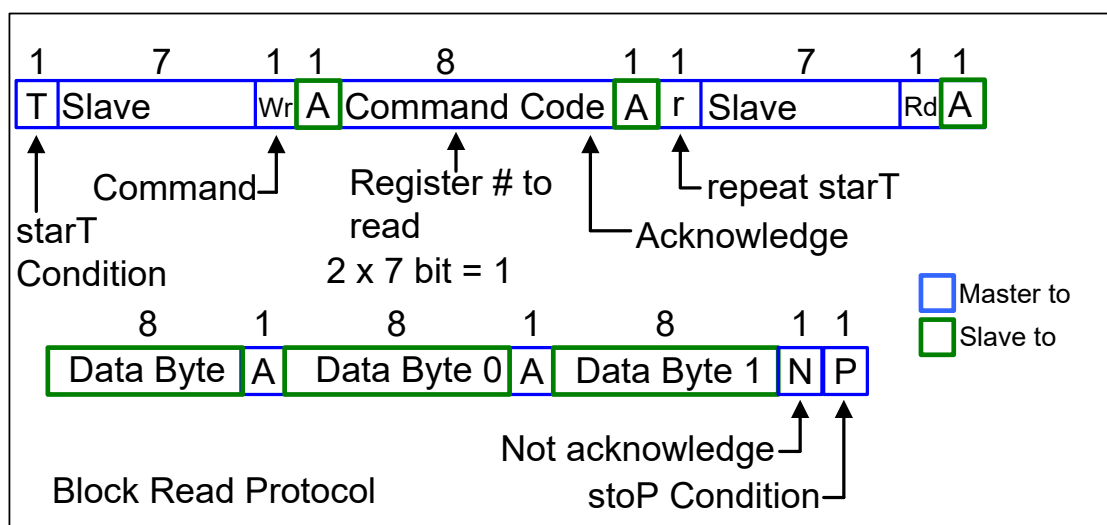


Figure 9. Block Read Protocol

### 4.2.2. Block Write

After the slave address is sent with the R/W condition bit not set, the command byte is sent with the MSB = 0. The lower seven bits indicate the register at which to start the transfer. If the command byte is 00h, the slave device will be compatible with existing block mode slave devices. The next byte of a write must be the count of bytes that the master will transfer to the slave device. The byte count must be greater than zero and less than 33. Following this byte are the data bytes to be transferred to the slave device. The slave device always acknowledges each byte received. The transfer is terminated after the slave sends the Ack and the master sends a stop function.

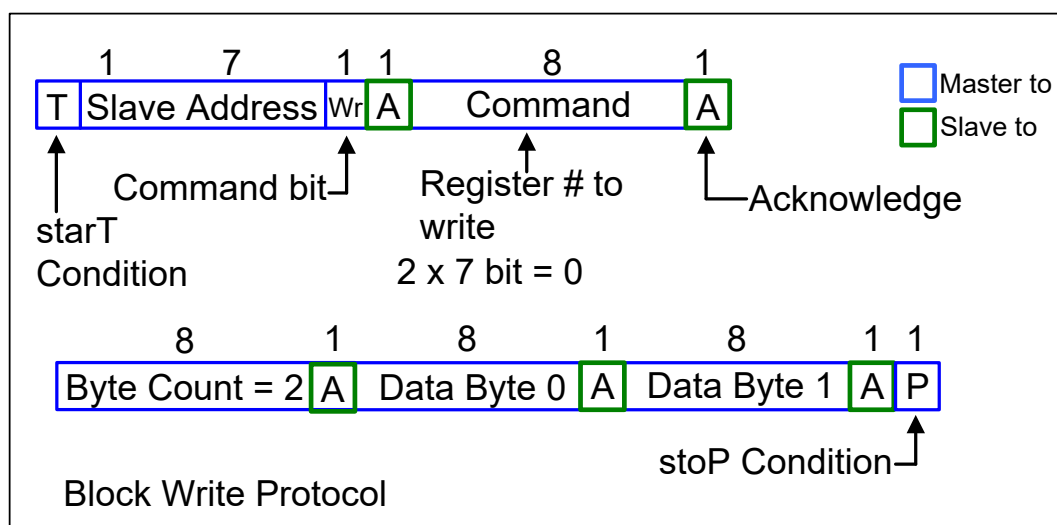


Figure 10. Block Write Protocol

## 4.3. Control Registers

**Table 19. Byte 0: Frequency Select, Output Enable, PLL Mode Control Register**

| Bit | Description                    | If Bit = 0                            | If Bit = 1    | Type | Default             | Output(s) Affected |
|-----|--------------------------------|---------------------------------------|---------------|------|---------------------|--------------------|
| 0   | 100M_133M#<br>Frequency Select | 133 MHz                               | 100 MHz       | R    | Latched at power up | DIF[11:0]          |
| 1   | PLL Mode 0                     | See PLL Operating Mode Readback Table |               | RW   | 1                   |                    |
| 2   | PLL Mode 1                     |                                       |               | RW   | 1                   |                    |
| 3   | PLL Software Enable            | HW Latch                              | SMBUS Control | RW   | 0                   |                    |
| 4   | Reserved                       |                                       |               |      | 0                   |                    |
| 5   | Reserved                       |                                       |               |      | 0                   |                    |
| 6   | PLL Mode 0                     | See PLL Operating Mode Readback Table |               | R    | Latched at power up |                    |
| 7   | PLL Mode 1                     | See PLL Operating Mode Readback Table |               | R    | Latched at power up |                    |

**Note:** Byte 0, bit\_[3:1] are BW PLL SW enable for the Si53108. Setting bit 3 to 1 allows the user to override the Latch value from pin 5 via use of bits 2 and 1. Use the values from the PLL Operating Mode Readback Table. Note that Bits 7 and 6 will keep the value originally latched on pin 5. A warm reset of the system will have to be accomplished if the user changes these bits.

Table 20. Byte 1: Output Enable Control Register

| Bit  | Description         | If Bit = 0          | If Bit = 1 | Type | Default | Output(s) Affected |
|--|---------------------|---------------------|------------|------|---------|--------------------|
| 0  | Reserved            |                     |            |      | 1       |                    |
| 1  | Output Enable DIF 0 | Low/Low for Si53108 | Enabled    | RW   | 1       | DIF[0]             |
| 2  | Output Enable DIF 1 | Low/Low for Si53108 | Enabled    | RW   | 1       | DIF[1]             |
| 3  | Reserved            |                     |            |      | 1       |                    |
| 4  | Output Enable DIF 2 | Low/Low for Si53108 | Enabled    | RW   | 1       | DIF[2]             |
| 5  | Output Enable DIF 3 | Low/Low for Si53108 | Enabled    | RW   | 1       | DIF[3]             |
| 6  | Output Enable DIF 4 | Low/Low for Si53108 | Enabled    | RW   | 1       | DIF[4]             |
| 7  | Output Enable DIF 5 | Low/Low for Si53108 | Enabled    | RW   | 1       | DIF[5]             |
| <b>Note:</b> Output Control — “0” overrides $\overline{OE}$ pin. |                     |                     |            |      |         |                    |

**Table 21. Byte 2: Output Enable Control Register**

| Bit | Description             | If Bit = 0 | If Bit = 1 | Type | Default | Output(s) Affected |
|-----|-------------------------|------------|------------|------|---------|--------------------|
| 0   | Output Enable for DIF 6 | Low/Low    | Enabled    | RW   | 1       | DIF[6]             |
| 1   | Reserved                |            |            |      | 1       |                    |
| 2   | Output Enable for DIF 7 | Low/Low    | Enabled    | RW   | 1       | DIF[7]             |
| 3   | Reserved                |            |            |      | 0       |                    |
| 4   | Reserved                |            |            |      | 0       |                    |
| 5   | Reserved                |            |            |      | 0       |                    |
| 6   | Reserved                |            |            |      | 0       |                    |
| 7   | Reserved                |            |            |      | 0       |                    |

**Table 22. Byte 3: Reserved Control Register**

| Bit | Description | If Bit = 0 | If Bit = 1 | Type | Default | Output(s) Affected |
|-----|-------------|------------|------------|------|---------|--------------------|
| 0   | Reserved    |            |            |      | 0       |                    |
| 1   | Reserved    |            |            |      | 0       |                    |
| 2   | Reserved    |            |            |      | 0       |                    |
| 3   | Reserved    |            |            |      | 0       |                    |
| 4   | Reserved    |            |            |      | 0       |                    |
| 5   | Reserved    |            |            |      | 0       |                    |
| 6   | Reserved    |            |            |      | 0       |                    |
| 7   | Reserved    |            |            |      | 0       |                    |



Table 23. Byte 4: Reserved Control Register

| Bit | Description | If Bit = 0 | If Bit = 1 | Type | Default | Output(s) Affected |
|-----|-------------|------------|------------|------|---------|--------------------|
| 0   | Reserved    |            |            |      | 0       |                    |
| 1   | Reserved    |            |            |      | 0       |                    |
| 2   | Reserved    |            |            |      | 0       |                    |
| 3   | Reserved    |            |            |      | 0       |                    |
| 4   | Reserved    |            |            |      | 0       |                    |
| 5   | Reserved    |            |            |      | 0       |                    |
| 6   | Reserved    |            |            |      | 0       |                    |
| 7   | Reserved    |            |            |      | 0       |                    |

Table 24. Byte 5: Vendor/Revision Identification Control Register

| Bit | Description         | If Bit = 0 | If Bit = 1 | Type | Default         | Default |
|-----|---------------------|------------|------------|------|-----------------|---------|
| 0   | Vendor ID Bit 0     |            |            | R    | Vendor Specific | 0       |
| 1   | Vendor ID Bit 1     |            |            | R    | Vendor Specific | 0       |
| 2   | Vendor ID Bit 2     |            |            | R    | Vendor Specific | 0       |
| 3   | Vendor ID Bit 3     |            |            | R    | Vendor Specific | 1       |
| 4   | Revision Code Bit 0 |            |            | R    | Vendor Specific | 0       |
| 5   | Revision Code Bit 1 |            |            | R    | Vendor Specific | 0       |
| 6   | Revision Code Bit 2 |            |            | R    | Vendor Specific | 0       |
| 7   | Revision Code Bit 3 |            |            | R    | Vendor Specific | 0       |

Table 25. Byte 6: Device ID Control Register

| Bit | Description       | If Bit = 0 | If Bit = 1 | Type | Default | Default |
|-----|-------------------|------------|------------|------|---------|---------|
| 0   | Device ID 0       |            |            | R    | 1       | 0       |
| 1   | Device ID 1       |            |            | R    | 1       | 0       |
| 2   | Device ID 2       |            |            | R    | 1       | 0       |
| 3   | Device ID 3       |            |            | R    | 0       | 0       |
| 4   | Device ID 4       |            |            | R    | 0       | 0       |
| 5   | Device ID 5       |            |            | R    | 1       | 0       |
| 6   | Device ID 6       |            |            | R    | 1       | 0       |
| 7   | Device ID 7 (MSB) |            |            | R    | 1       | 0       |

**Table 26. Byte 7: Byte Count Register**

| Bit | Description  | If Bit = 0 | If Bit = 1 | Type | Default | Output(s) Affected |
|-----|--|------------|------------|------|---------|--------------------|
| 0   | BC0 - Writing to this register configures how many bytes will be read back |            |            | RW   | 0       |                    |
| 1   | BC1 -Writing to this register configures how many bytes will be read back  |            |            | RW   | 0       |                    |
| 2   | BC2 -Writing to this register configures how many bytes will be read back  |            |            | RW   | 0       |                    |
| 3   | BC3 -Writing to this register configures how many bytes will be read back  |            |            | RW   | 1       |                    |
| 4   | BC4 -Writing to this register configures how many bytes will be read back  |            |            | RW   | 0       |                    |
| 5   | Reserved   |            |            |      | 0       |                    |
| 6   | Reserved   |            |            |      | 0       |                    |
| 7   | Reserved   |            |            |      | 0       |                    |

## 5. Power Filtering Example

### 5.1. Ferrite Bead Power Filtering

Skyworks Solutions recommends using a ferrite bead with characteristics matching Murata BLM15EG221SN1.

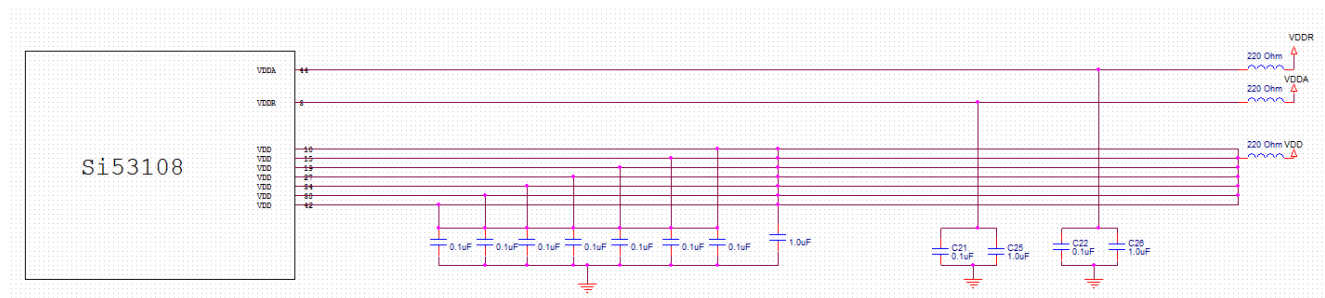


Figure 11. Recommended Si53108 Power Filtering

# Si53108

## 6. Pin Descriptions: 48-Pin QFN

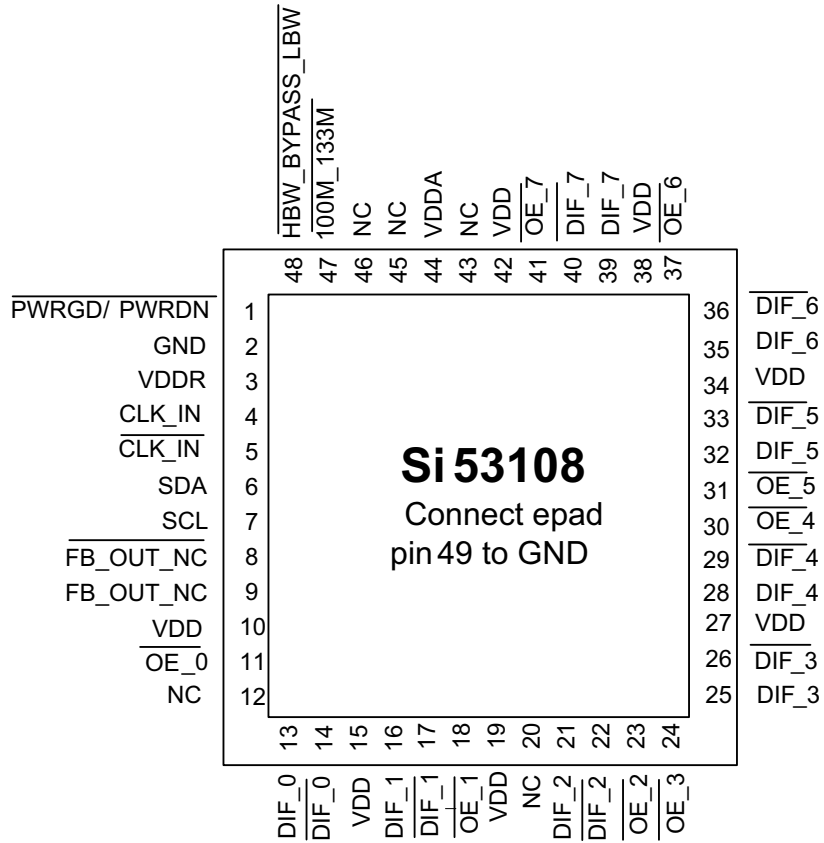


Table 27. Si53108 48-Pin QFN Descriptions

| Pin # | Name                            | Type   | Description  |
|-------|---------------------------------|--------|--|
| 1     | $\overline{\text{PWRGD/PWRDN}}$ | I      | 3.3 V LVTTTL input to power up or power down the device.   |
| 2     | GND                             | GND    | Connect this pin to ground.  |
| 3     | VDDR                            | VDD    | 3.3 V power supply for differential input receiver. This VDDR should be treated as an analog power rail and filtered appropriately.    |
| 4     | CLK_IN                          | I, DIF | 0.7 V Differential input.  |
| 5     | $\overline{\text{CLK\_IN}}$     | I, DIF | 0.7 V Differential input.  |
| 6     | SDA                             | I/O    | Open collector SMBus data.   |
| 7     | SCL                             | I/O    | SMBus slave clock input.   |
| 8     | $\overline{\text{FB\_OUT\_NC}}$ | I/O    | No connect. There are active signals on pin 8 and 9, do not connect anything to these pins.  |
| 9     | FB_OUT_NC                       | I/O    | No connect. There are active signals on pin 8 and 9, do not connect anything to these pins.  |
| 10    | VDD                             | 3.3 V  | 3.3 V power supply   |
| 11    | $\overline{\text{OE\_0}}$       | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down. |
| 12    | NC                              | -      | Do not connect this pin to anything.   |
| 13    | DIF_0                           | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 14    | $\overline{\text{DIF\_0}}$      | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 15    | VDD                             | 3.3 V  | 3.3 V power supply for outputs.  |
| 16    | DIF_1                           | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 17    | $\overline{\text{DIF\_1}}$      | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 18    | $\overline{\text{OE\_1}}$       | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down. |
| 19    | VDD                             | 3.3 V  | 3.3 V power supply   |
| 20    | NC                              | -      | Do not connect this pin to anything.   |
| 21    | DIF_2                           | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 22    | $\overline{\text{DIF\_2}}$      | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 23    | $\overline{\text{OE\_2}}$       | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down. |
| 24    | $\overline{\text{OE\_3}}$       | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down. |
| 25    | DIF_3                           | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 26    | $\overline{\text{DIF\_3}}$      | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |

Table 27. Si53108 48-Pin QFN Descriptions

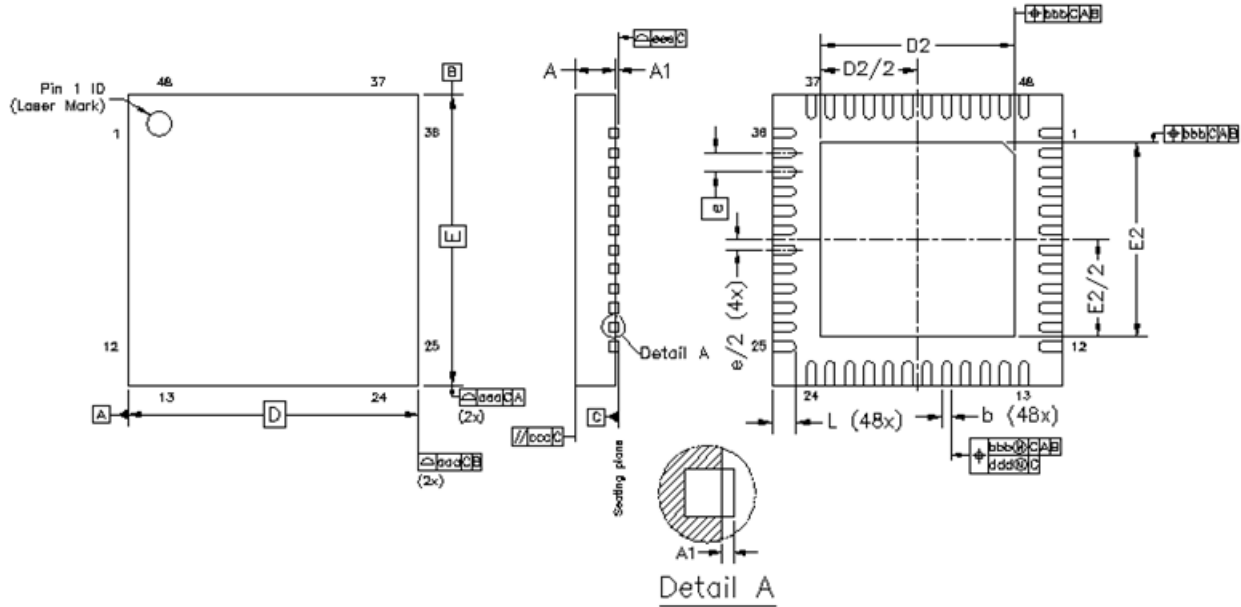
| Pin # | Name                                 | Type   | Description  |
|-------|--------------------------------------|--------|--|
| 27    | VDD                                  | 3.3 V  | 3.3 V power supply   |
| 28    | DIF_4                                | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 29    | $\overline{\text{DIF}}_4$            | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 30    | $\overline{\text{OE}}_4$             | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down.   |
| 31    | $\overline{\text{OE}}_5$             | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down.   |
| 32    | DIF_5                                | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 33    | $\overline{\text{DIF}}_5$            | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 34    | VDD                                  | 3.3 V  | 3.3 V power supply   |
| 35    | DIF_6                                | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 36    | $\overline{\text{DIF}}_6$            | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 37    | $\overline{\text{OE}}_6$             | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down.   |
| 38    | VDD                                  | 3.3 V  | 3.3 V power supply   |
| 39    | DIF_7                                | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 40    | $\overline{\text{DIF}}_7$            | O, DIF | 0.7 V Differential clock output. Default is 1:1.   |
| 41    | $\overline{\text{OE}}_7$             | I, SE  | 3.3 V LVTTTL active low input for enabling differential outputs (default). Controls the corresponding output pair. Internal pull-down.   |
| 42    | VDD                                  | 3.3 V  | 3.3 V power supply   |
| 43    | NC                                   | -      | Do not connect this pin to anything.   |
| 44    | VDDA                                 | 3.3V   | 3.3 V power supply for PLL.  |
| 45    | NC                                   | -      | Do not connect this pin to anything.   |
| 46    | NC                                   | -      | Do not connect this pin to anything.   |
| 47    | $\overline{100\text{M}}_133\text{M}$ | I,SE   | 3.3 V tolerant inputs for input/output frequency selection. An external pull-up or pull-down resistor is attached to this pin to select the input/output frequency.<br>High = 100 MHz output<br>Low = 133 MHz output |
| 48    | $\overline{\text{HBW\_BYPASS\_LBW}}$ | I, SE  | Tri-Level input for selecting the PLL bandwidth or bypass mode.<br>High = High BW mode<br>Med = Bypass mode<br>Low = Low BW mode   |
| 49    | GND                                  | GND    | Ground epad to GND.  |

## 7. Ordering Guide

| <b>Part Number</b> | <b>Package Type</b>      | <b>Temperature</b>     |
|--------------------|--------------------------|------------------------|
| <b>Lead-free</b>   |                          |                        |
| Si53108-A01AGM     | 48-pin QFN               | Extended, –40 to 85 °C |
| Si53108-A01AGMR    | 48-pin QFN—Tape and Reel | Extended, –40 to 85 °C |

## 8. Package Outline

Figure 12 illustrates the package details for the Si53108. Table 28 lists the values for the dimensions shown in the illustration.



**Figure 12. 48-Pin Quad Flat No Lead (QFN) Package**

**Table 28. Package Diagram Dimensions**

| Dimension  | Min       | Nom  | Max  |
|--|-----------|------|------|
| A  | 0.80      | 0.85 | 0.90 |
| A1   | 0.00      | 0.02 | 0.05 |
| b  | 0.15      | 0.20 | 0.25 |
| D  | 6.00 BSC. |      |      |
| D2   | 3.50      | 3.60 | 3.70 |
| e  | 0.40 BSC. |      |      |
| E  | 6.00 BSC. |      |      |
| E2   | 3.50      | 3.60 | 3.70 |
| L  | 0.30      | 0.40 | 0.50 |
| aaa  | 0.10      |      |      |
| bbb  | 0.10      |      |      |
| ccc  | 0.10      |      |      |
| <b>Notes:</b>  |           |      |      |
| 1. All dimensions shown are in millimeters (mm) unless otherwise noted.                                    |           |      |      |
| 2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.  |           |      |      |
| 3. This drawing conforms to JEDEC outline MO-220   |           |      |      |
| 4. Recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components. |           |      |      |

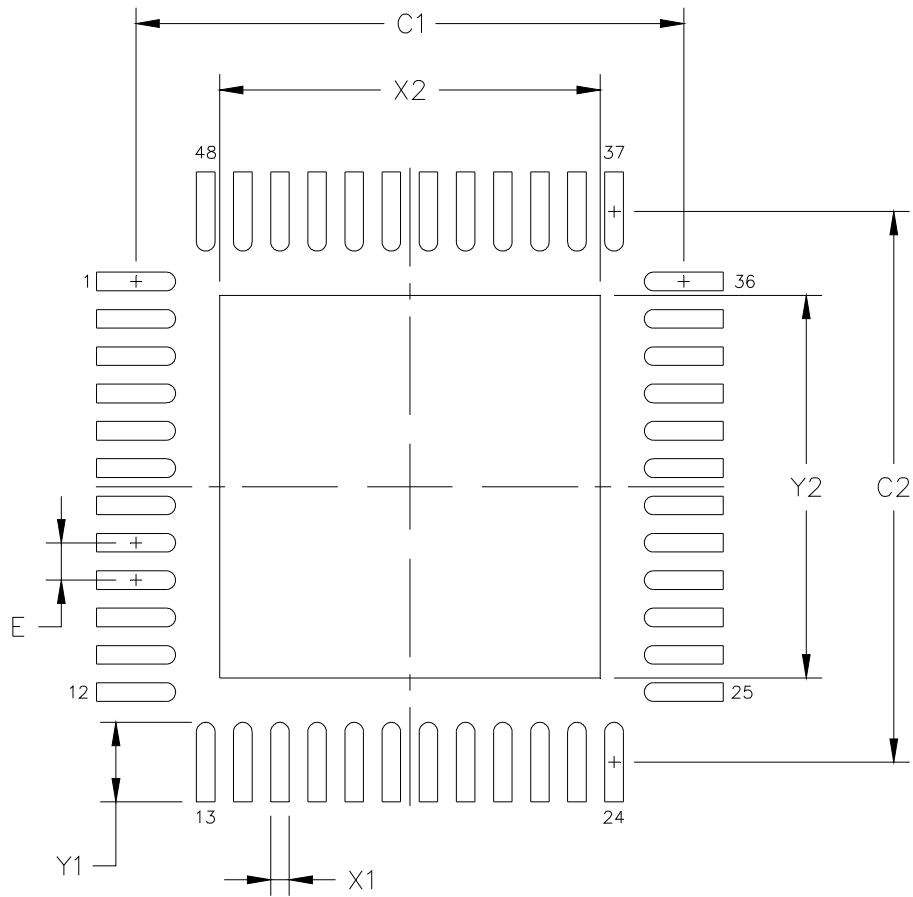


Table 28. Package Diagram Dimensions

| Dimension   | Min | Nom  | Max |
|---|-----|------|-----|
| ddd   |     | 0.10 |     |
| eee   |     | 0.08 |     |
| <b>Notes:</b> <ol style="list-style-type: none"><li>1. All dimensions shown are in millimeters (mm) unless otherwise noted.</li><li>2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.</li><li>3. This drawing conforms to JEDEC outline MO-220</li><li>4. Recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.</li></ol> |     |      |     |

## 9. Land Pattern

Figure 13 illustrates the recommended land pattern details for the Si53108 in a 48-pin QFN package. Table 29 lists the values for the dimensions shown in the illustration.



**Figure 13. Land Pattern**

Table 29. PCB Land Pattern Dimensions

| Dimension | mm   |
|-----------|------|
| C1        | 5.90 |
| C2        | 5.90 |
| E         | 0.40 |
| X1        | 0.20 |
| Y1        | 0.85 |
| X2        | 4.10 |
| Y2        | 4.10 |

**Notes:**

**General**

1. All dimensions shown are in millimeters (mm).
2. This Land Pattern Design is based on the IPC-7351 guidelines.
3. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

**Solder Mask Design**

4. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60  $\mu\text{m}$  minimum, all the way around the pad.

**Stencil Design**

5. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
6. The stencil thickness should be 0.125 mm (5 mils).
7. The ratio of stencil aperture to land pad size should be 1:1 for all perimeter pads.
8. A 3x3 array of 1.0 mm square openings on a 1.5 mm pitch should be used for the center ground pad.

**Card Assembly**

9. A No-Clean, Type-3 solder paste is recommended.
10. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

## DOCUMENT CHANGE LIST

### Revision 1.0 to Revision 1.1

- Updated PLL Bandwidth Specifications in Table 6.

### Revision 1.1 to Revision 1.2

- Updated Features on page 1.
- Updated Description on page 1.
- Updated specs in Table 7, “Phase Jitter,” on page 7.



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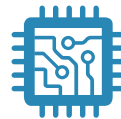
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